

International IR Rectifier

- Advanced Process Technology
- Surface Mount (IRF520NS)
- Low-profile through-hole (IRF520NL)
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

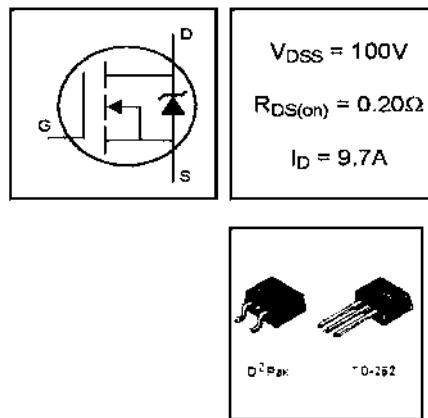
Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The D²Pak is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D²Pak is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application. The through-hole version (IRF520NL) is available for low-profile applications.

PD-95749

IRF520NSPbF IRF520NLPbF



Absolute Maximum Ratings

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V⑤	9.7	A
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V⑤	6.8	
I _{DM}	Pulsed Drain Current ①⑤	38	
P _D @ T _A = 25°C	Power Dissipation	3.8	W
P _D @ T _C = 25°C	Power Dissipation	48	W
V _{GS}	Linear Derating Factor	0.32	W/°C
	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy②⑤	91	mJ
I _{AR}	Avalanche Current①	5.7	A
E _{AR}	Repetitive Avalanche Energy①	4.8	mJ
dv/dt	Peak Diode Recovery dv/dt ③⑤	5.0	V/ns
T _J	Operating Junction and	-55 to + 175	°C
T _{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

Thermal Resistance

	Parameter	Typ.	Max.	Units
R _{θJC}	Junction-to-Case	—	3.1	°C/W
R _{θJA}	Junction-to-Ambient (PCB Mounted,steady-state)**	—	40	

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Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DS}$	Drain-to-Source Breakdown Voltage	100	—	—	V
$\Delta V_{(BR)DS}/\Delta T_c$	Breakdown Voltage Temp. Coefficient	—	0.11	—	$V^\circ\text{C}$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	0.20	Ω
$V_{GS(th)}$	Gate Threshold Voltage	2.0	—	4.0	V
g_{fs}	Forward Transconductance	2.7	—	—	S
I_{DS}	Drain-to-Source Leakage Current	—	—	25	μA
		—	—	250	μA
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA
	Gate-to-Source Reverse Leakage	—	—	-100	nA
Q_g	Total Gate Charge	—	—	25	
Q_{gs}	Gate-to-Source Charge	—	—	4.8	nC
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	11	
$t_{d(on)}$	Turn-On Delay Time	—	—	4.5	
t_r	Rise Time	—	—	23	ns
$t_{d(off)}$	Turn-Off Delay Time	—	—	32	ns
t_f	Fall Time	—	—	23	ns
L_s	Internal Source Inductance	—	—	7.5	nH
C_{ss}	Input Capacitance	—	—	330	—
C_{oss}	Output Capacitance	—	—	92	pF
C_{rtt}	Reverse Transfer Capacitance	—	—	54	—
					$f = 1.0\text{MHz}$, See Fig. 5③

Source-Drain Ratings and Characteristics

Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	9.7	A
I_{SM}	Pulsed Source Current (Body Diode) ①②	—	—	38	
V_{SD}	Diode Forward Voltage	—	—	1.3	V
t_r	Reverse Recovery Time	—	99 150	ns	$T_c = 25^\circ\text{C}$, $I_S = 5.7\text{A}$, $V_{GS} = 0\text{V}$ ④
Q_r	Reverse Recovery Charge	—	390 580	nC	$di/dt = 100\text{A}/\mu\text{s}$ ④⑤
t_{or}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_s + L_D$)			

Notes:

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

④ Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.

② $V_{DD} = 25\text{V}$, starting $T_c = 25^\circ\text{C}$, $L = 4.7\text{mH}$
 $R_G = 25\Omega$, $I_{AS} = 5.7\text{A}$. (See Figure 12)

⑤ Uses IRF520N data and test conditions

③ $I_{SD} \leq 5.7\text{A}$, $di/dt \leq 240\text{A}/\mu\text{s}$, $V_{DD} \leq V_{(BR)DSS}$,
 $T_J < 175^\circ\text{C}$

** When mounted on FR-4 board using minimum recommended footprint.
For recommended footprint and soldering techniques refer to application note #AN-994.

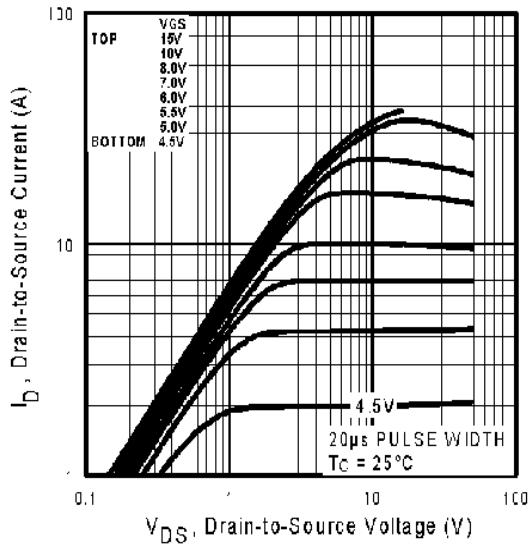


Fig 1. Typical Output Characteristics

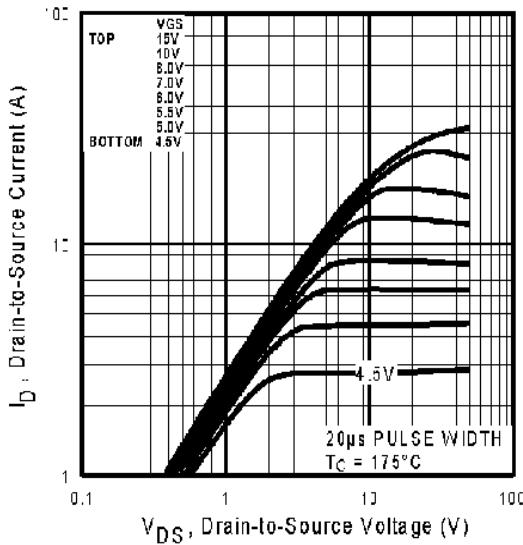


Fig 2. Typical Output Characteristics

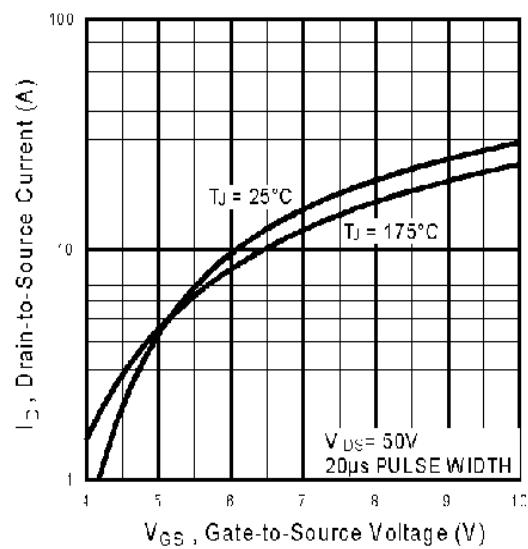


Fig 3. Typical Transfer Characteristics

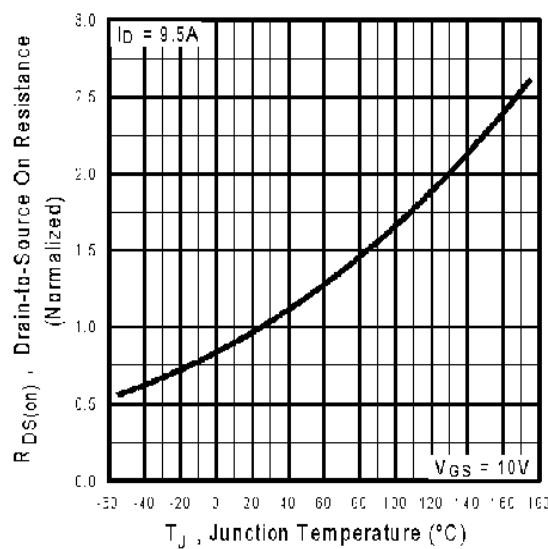


Fig 4. Normalized On-Resistance
Vs. Temperature

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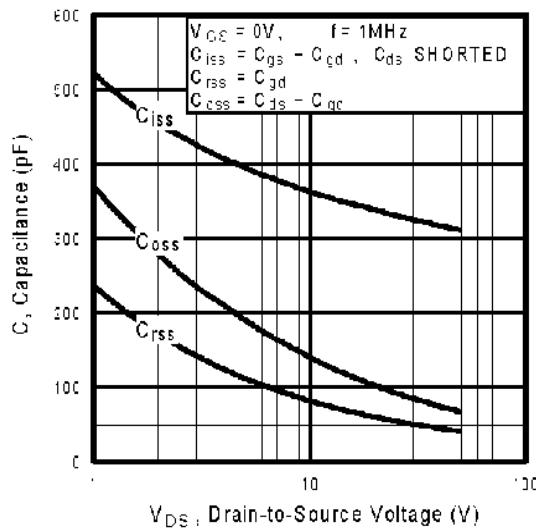


Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage

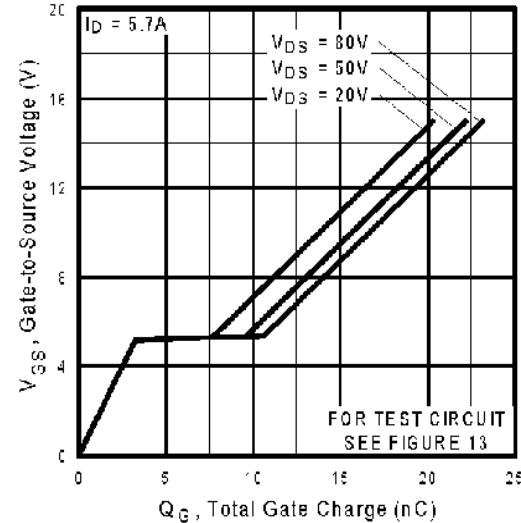


Fig 6. Typical Gate Charge Vs.
Gate-to-Source Voltage

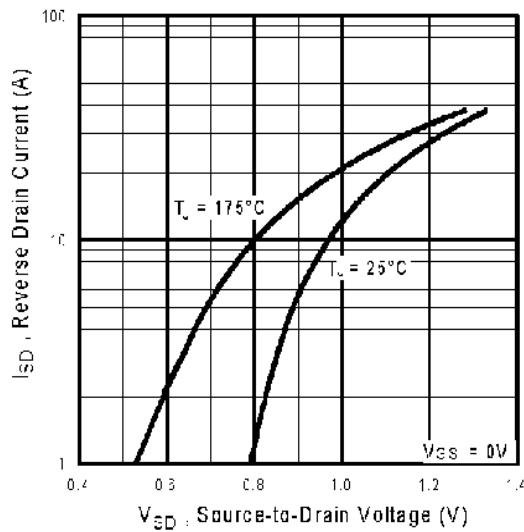


Fig 7. Typical Source-Drain Diode
Forward Voltage

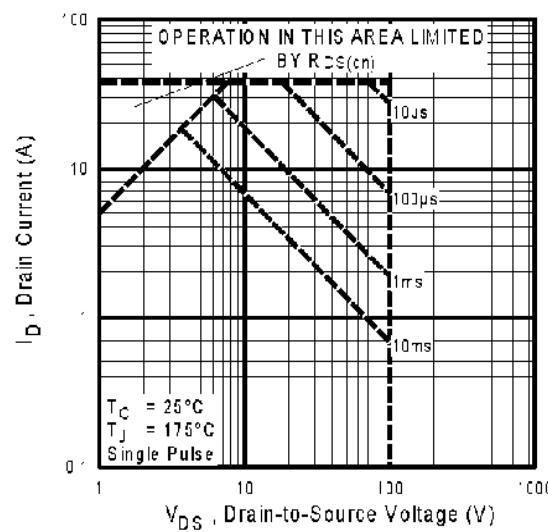


Fig 8. Maximum Safe Operating Area

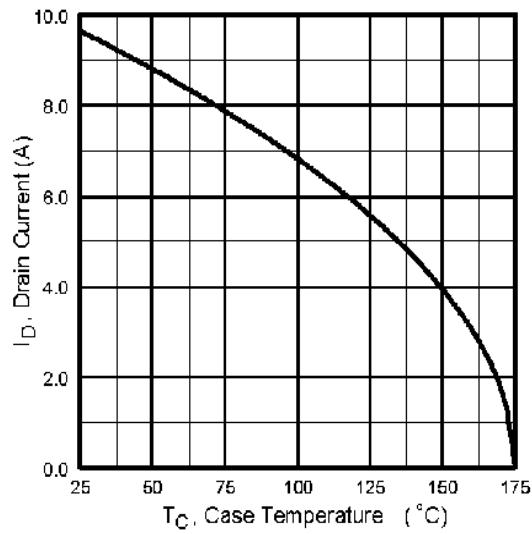


Fig 9. Maximum Drain Current Vs.
Case Temperature

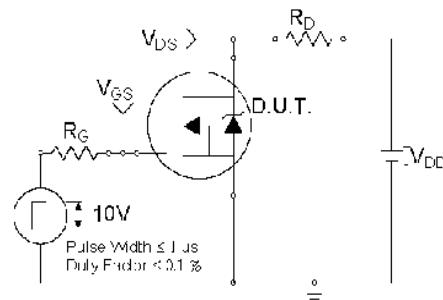


Fig 10a. Switching Time Test Circuit

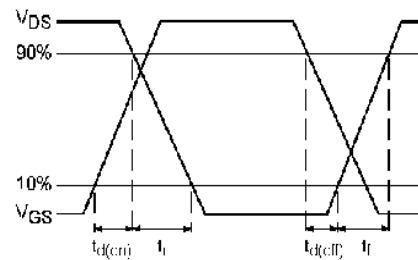


Fig 10b. Switching Time Waveforms

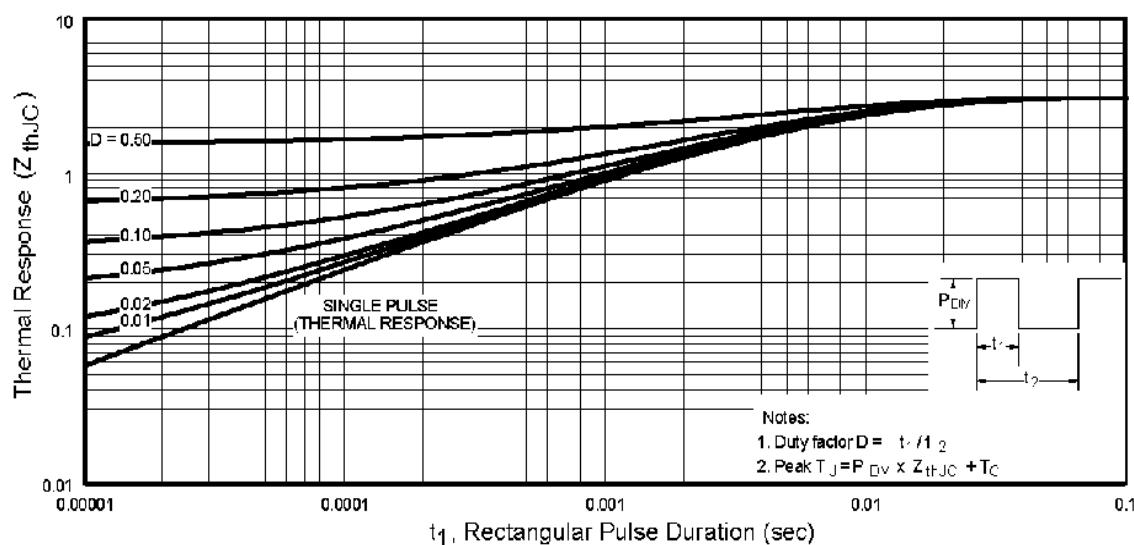


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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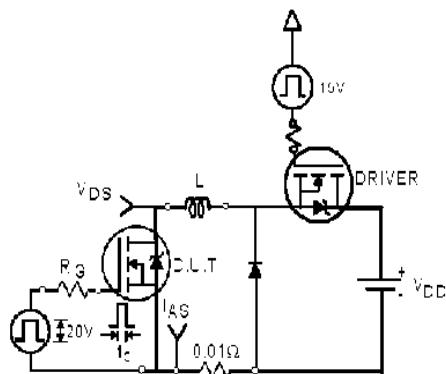


Fig 12a. Unclamped Inductive Test Circuit

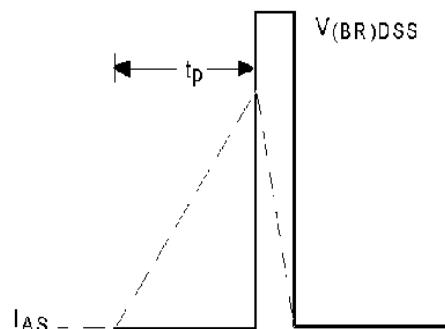


Fig 12b. Unclamped Inductive Waveforms

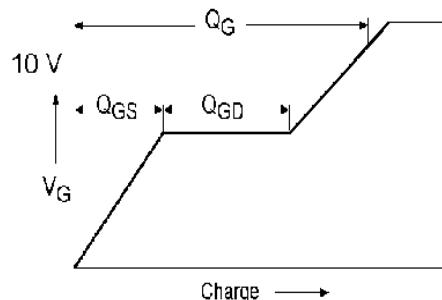


Fig 13a. Basic Gate Charge Waveform

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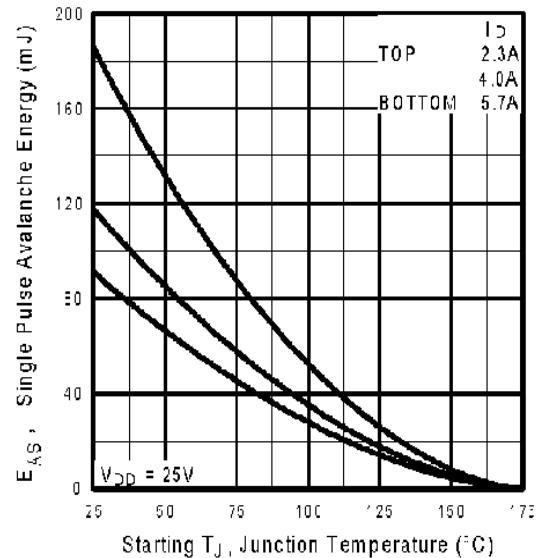


Fig 12c. Maximum Avalanche Energy
Vs. Drain Current

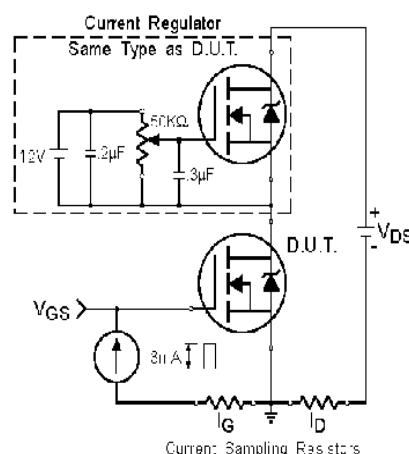
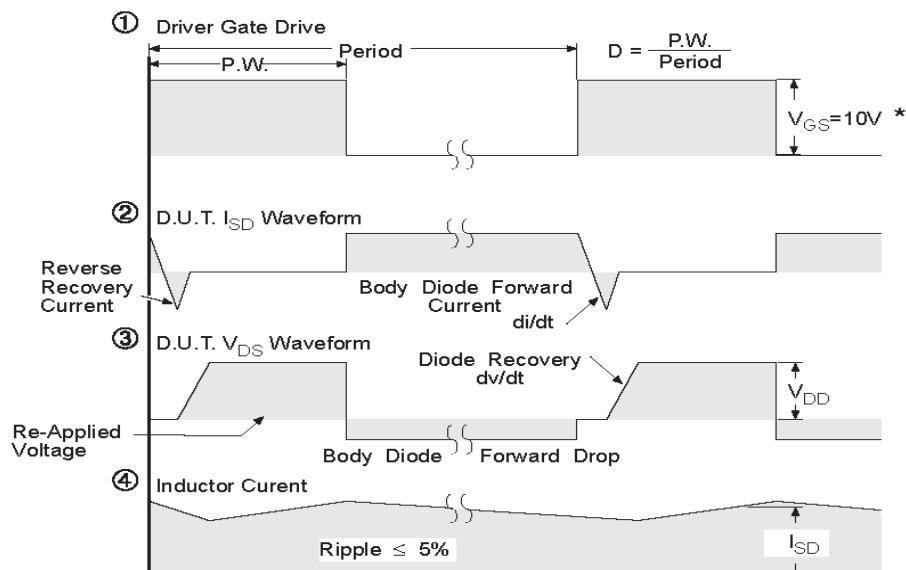
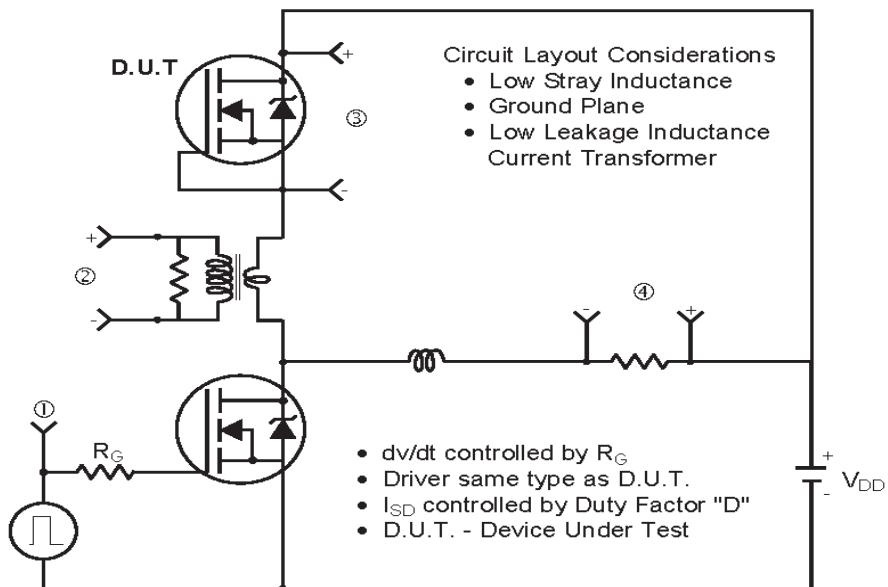


Fig 13b. Gate Charge Test Circuit

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Peak Diode Recovery dv/dt Test Circuit



* $V_{GS} = 5V$ for Logic Level Devices

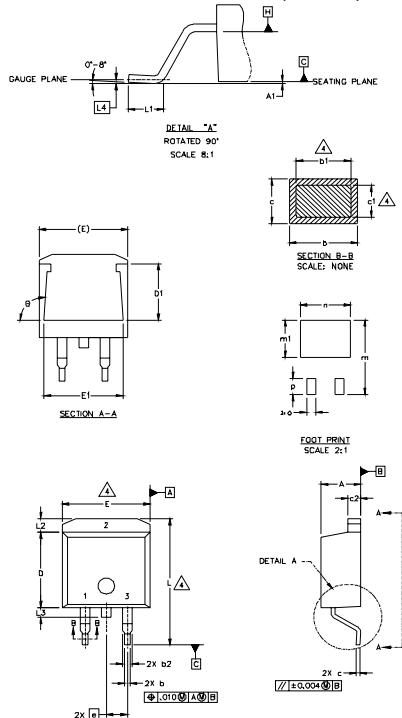
Fig 14. For N-Channel HEXFETs

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D²Pak Package Outline

Dimensions are shown in millimeters (inches)



SYMBOL	DIMENSIONS				NOTES	
	MILLIMETERS		INCHES			
	MIN.	MAX.	MIN.	MAX.		
A	4.06	4.83	.160	.190		
A1		0.127		.005		
b	0.51	0.99	.020	.039	4	
b1	0.51	0.89	.020	.035		
b2	1.14	1.40	.045	.055		
c	0.43	0.63	.017	.025		
c1	0.38	0.74	.015	.029	4	
c2	1.14	1.40	.045	.055		
D	8.51	9.65	.335	.380	3	
D1	5.33		.210			
E	9.65	10.67	.380	.420	3	
E1	6.22		.245			
e	2.54	BSC	.100	BSC		
L	14.61	15.88	.575	.625		
L1	1.78	2.79	.070	.110		
L2		1.65		.065		
L3	1.27	1.78	.050	.070		
L4	0.25	BSC	.010	BSC		
m	17.78		.700			
m1	8.89		.350			
n	11.43		.450			
o	2.08		.082			
p	3.81		.150			
theta	90°	93°	90°	93°		

LEAD ASSIGNMENTS

HEXFET	IGBTs_CoPACK	DIODES
1.— GATE	1.— GATE	1.— ANODE *
2.— DRAIN	2.— COLLECTOR	2.— CATHODE
3.— SOURCE	3.— Emitter	3.— ANODE

* PART DEPENDENT.

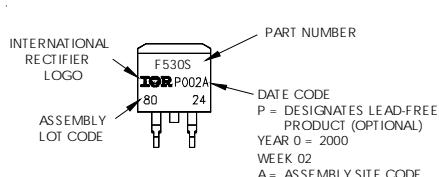
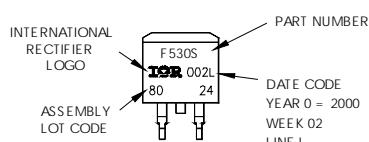
- NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]
 3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
 4. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
 5. CONTROLLING DIMENSION: INCH.



D²Pak Part Marking Information

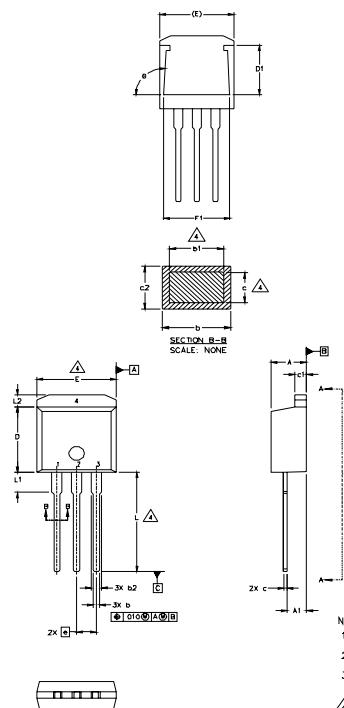
EXAMPLE: THIS IS AN IRF530S WITH
LOT CODE 8024
ASSEMBLED ON WW 02, 2000
IN THE ASSEMBLY LINE "L"

Note: "P" in assembly line position indicates "Lead-Free"



TO-262 Package Outline

Dimensions are shown in millimeters (inches)



SYMBOL	DIMENSIONS				NOTES	
	MILLIMETERS		INCHES			
	MIN.	MAX.	MIN.	MAX.		
A	4.06	4.83	.160	.190		
A1	2.03	2.92	.080	.115		
b	0.51	0.99	.020	.039		
b1	0.51	0.89	.020	.035		
b2	1.14	1.40	.045	.055		
c	0.38	0.63	.015	.025		
c1	1.14	1.40	.045	.055		
c2	0.43	.063	.017	.029		
D	8.51	9.65	.335	.380		
D1	5.33		.210			
E	9.65	10.67	.380	.420		
E1	6.22		.245			
e	2.54	BSC	.100	BSC		
L	13.46	14.09	.530	.555		
L1	3.56	3.71	.140	.146		
L2		1.65		.065		

LEAD ASSIGNMENTS

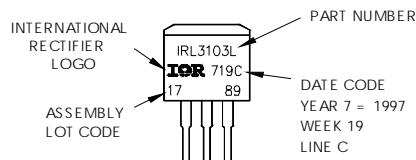
HEXFET	IGBT
1 - GATE	1 - GATE
2 - DRAIN	2 - COLLECTOR
3 - SOURCE	3 - Emitter
4 - DRAIN	

- NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]
 3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
 4. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY
 5. CONTROLLING DIMENSION: INCH.

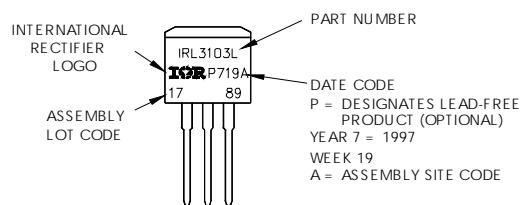
TO-262 Part Marking Information

EXAMPLE: THIS IS AN IRL3103L
LOT CODE 1789
ASSEMBLED ON WW 19, 1997
IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line
position indicates "Lead-Free"



OR

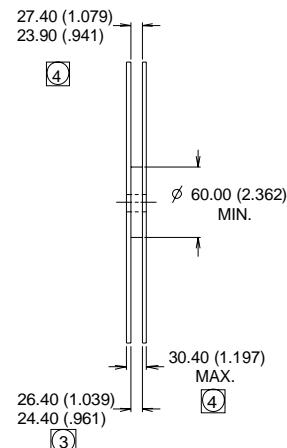
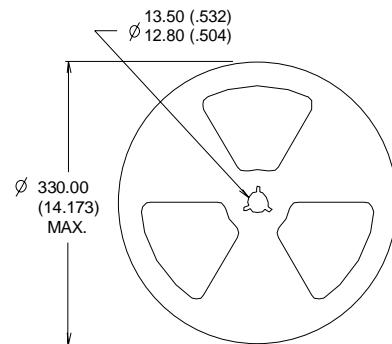
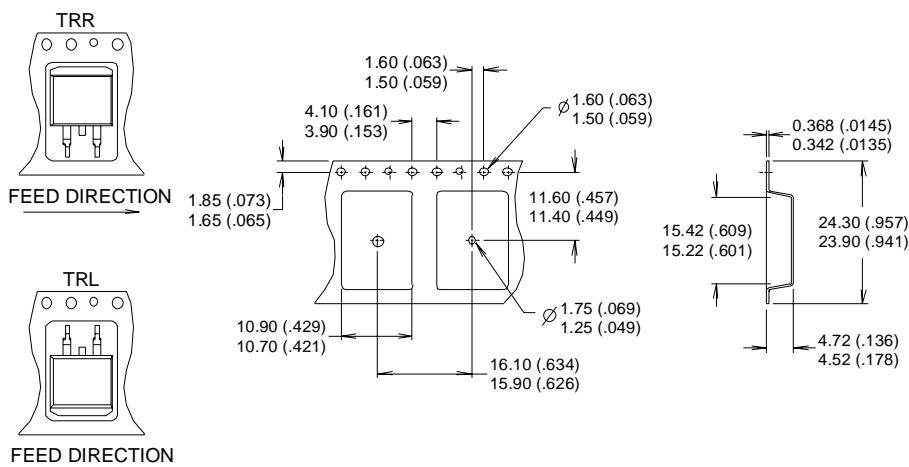


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D²Pak Tape & Reel Information

Dimensions are shown in millimeters (inches)



- NOTES :
1. CONFORMS TO EIA-418.
 2. CONTROLLING DIMENSION: MILLIMETER.
 3. DIMENSION MEASURED @ HUB.
 4. INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Data and specifications subject to change without notice.

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TAC Fax: (310) 252-7903

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Note: For the most current drawings please refer to the IR website at:
<http://www.irf.com/package/>